

**M. Flom Associates, Inc. - Global Compliance Center**

3356 North San Marcos Place, Suite 107, Chandler, Arizona 85225-7176

www.mflom.com general@mflom.com (480) 926-3100, FAX: 926-3598

Date: March 17, 2000

Federal Communications Commission
Via: Electronic Filing

Attention: Authorization & Evaluation Division

Applicant: Nokia Mobile Phones, Inc.
Equipment: 8260, Type NSW-4DX
FCC ID: GMLNSW-4DX
FCC Rules: 22, 24, Confidentiality

Gentlemen:

On behalf of the Applicant, enclosed please find Application Form 731, Engineering Test Report and all pertinent documentation, the whole for approval of the referenced equipment as shown.

Filing fees are attached.

We trust the same is in order. Should you need any further information, kindly contact the writer who is authorized to act as agent.

Sincerely yours,

A handwritten signature in black ink, appearing to read 'William H. Graff', written over a horizontal line.

William H. Graff, Director
of Engineering

enclosure(s)
cc: Applicant
WHG/cvr

LIST OF EXHIBITS
(FCC **CERTIFICATION** (CELLULAR TRANSMITTERS) - REVISED 9/28/98)

APPLICANT: Nokia Mobile Phones, Inc.

FCC ID: GMLNSW-4DX

BY APPLICANT:

1. LETTER OF AUTHORIZATION
2. IDENTIFICATION DRAWINGS, 2.1033(c)(11)
 - _____ LABEL
 - _____ LOCATION OF LABEL
 - _____ COMPLIANCE STATEMENT
 - _____ LOCATION OF COMPLIANCE STATEMENT
3. PHOTOGRAPHS, 2.1033(c)(12)
4. CONFIDENTIALITY REQUEST: 0.457 and 0.459
5. DOCUMENTATION: 2.1033(c)
 - (3) USER MANUAL
 - (9) TUNE UP INFO
 - (10) SCHEMATIC DIAGRAM
 - (10) CIRCUIT DESCRIPTION
 - BLOCK DIAGRAM
 - PARTS LIST
 - ACTIVE DEVICES
6. ATTESTATION: ESN: Section 22.919
7. ATTESTATION: OET: Section 22.933

BY M.F.A. INC.

- A. TESTIMONIAL & STATEMENT OF CERTIFICATION
- B. STATEMENT OF QUALIFICATIONS



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Sub-part
2.1033 (c) :

EQUIPMENT IDENTIFICATION

FCC ID: GMLNSW-4DX

NAMEPLATE DRAWING

ATTACHED, EXHIBIT 1.

LOCATION

AS PER LABEL DRAWING(S)

DATE OF REPORT

March 17, 2000

SUPERVISED BY:

A handwritten signature in black ink, appearing to read 'William H. Graff', is positioned above the printed name.

William H. Graff, Director
of Engineering

THE APPLICANT HAS BEEN CAUTIONED AS TO THE FOLLOWING:

15.21 INFORMATION TO USER.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) SPECIAL ACCESSORIES.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.

Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

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Required information per ISO/IEC Guide 25-1990, paragraph 13.2:

a) TEST REPORT

b) Laboratory: M. Flom Associates, Inc.
(FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107
(Canada: IC 2044) Chandler, AZ 85225

c) Report Number: d0030044

d) Client: Nokia Mobile Phones
6000 Connection Drive
Irving, TX 75039

e) Identification: 8260, Type NSW-4DX
FCC ID: GMLNSW-4DX
Description: Dual Band Tri-Mode TDMA Cellular Transceiver

f) EUT Condition: Not required unless specified in individual tests.

g) Report Date: March 17, 2000
EUT Received: February 7, 2000

h, j, k): As indicated in individual tests.

i) Sampling method: No sampling procedure used.

l) Uncertainty: In accordance with MFA internal quality manual.

m) Supervised by:



William H. Graff, Director
of Engineering

n) Results: The results presented in this report relate only to the item tested.

o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

PAGE NO. 2 of 72.

LIST OF GENERAL INFORMATION REQUIRED FOR CERTIFICATION

IN ACCORDANCE WITH FCC RULES AND REGULATIONS,
VOLUME II, PART 2 AND TO

22, 24, Confidentiality

Sub-part 2.1033

(c) (1): NAME AND ADDRESS OF APPLICANT:

Nokia Mobile Phones, Inc.
6200 Courtney Campbell Causeway, Suite 900
P.O. Box 30730
Tampa, Florida 33630-3730

MANUFACTURER:

Nokia Mobile Phones Manufacturing (USA), Inc.
5650 Alliance Gateway
Fort Worth, TX 76178

(c) (2): FCC ID: GMLNSW-4DX

MODEL NO: 8260, Type NSW-4DX

(c) (3): INSTRUCTION MANUAL(S):

PLEASE SEE ATTACHED EXHIBITS

(c) (4): TYPE OF EMISSION: 40K0F1D, 40K0F8W, 30K0DXW

(c) (5): FREQUENCY RANGE, MHz: 824 to 849
1850 to 1910

(c) (6): POWER RATING, Watts: 0.006 to 0.162
___ Switchable ___ x Variable ___ N/A

FCC GRANT NOTE: BC - The output value listed above to
5%-10% of the value listed.

(c) (7): MAXIMUM POWER RATING, Watts: 7

PAGE NO. 3 of 72.

Subpart 2.1033 (continued)

(c) (8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE,
INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual
COLLECTOR VOLTAGE, Vdc = per manual
SUPPLY VOLTAGE, Vdc = 3.6

(c) (9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c) (10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for
determining and stabilizing frequency, for suppression of
spurious radiation, for limiting modulation and limiting
power.

PLEASE SEE ATTACHED EXHIBITS

(c) (11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c) (12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c) (13): DIGITAL MODULATION DESCRIPTION:

____ ATTACHED EXHIBITS
x N/A

(c) (14): TEST AND MEASUREMENT DATA:

FOLLOWS

PAGE NO.

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M. Flom Associates, Inc. is accredited by the American Association for Laboratory Accreditation (A2LA) as shown in the scope below.



**THE AMERICAN
ASSOCIATION
FOR LABORATORY
ACCREDITATION**

ACCREDITED LABORATORY

A2LA has accredited

M. FLOM ASSOCIATES, INC.
Chandler, AZ

for technical competence in the field of

Electrical (EMC) Testing

The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO/IEC Guide 25-1990 "General Requirements for the Competence of Calibration and Testing Laboratories" (equivalent to relevant requirements of the ISO 9000 series of standards) and any additional program requirements in the identified field of testing.

Presented this 24th day of November, 1998.



Peter Rhyne
President
For the Accreditation Council
Certificate Number 1008.01
Valid to December 31, 2000

For tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical (EMC) Scope of Accreditation



American Association for Laboratory Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC GUIDE 25-1990 AND EN 45001

M. FLOM ASSOCIATES, INC.
Electronic Testing Laboratory
3356 North San Marcos Place, Suite 107
Chandler, AZ 85225
Morton Flom Phone: 480 926 3100

ELECTRICAL (EMC)

Valid to: December 31, 2000 Certificate Number: 1008-01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following electromagnetic compatibility tests:

Tests	Standard(s)
RF Emissions	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; FCC Part 18; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438
RF Immunity	EN 50082-1; EN 50082-2; AS/NZS 4251.1
Radiated Susceptibility	EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3
ESD	EN 61000-4-2; IEC 1000-4-2; IEC 801-2
EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4
Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5
47 CFR (FCC)	2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97

Revised 2/2/2000

Peter Rhyne

5301 Buckeystown Pike, Suite 350 • Frederick, MD 21704-8370 • Phone: 301 644 3248 • Fax: 301 662 2974

"This laboratory is accredited by the American Association for Laboratory Accreditation (A2LA) and the results shown in this report have been determined in accordance with the laboratory's terms of accreditation unless stated otherwise in the report."

Should this report contain any data for tests for which we are not accredited, or which have been undertaken by a subcontractor that is not A2LA accredited, such data would not be covered by this laboratory's A2LA accreditation.

PAGE NO.

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Sub-part

2.1033(c) (14) :

TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- ☐ 21 - Domestic Public Fixed Radio Services
- ☒ 22 - Public Mobile Services
- ☐ 22 Subpart H - Cellular Radiotelephone Service
- ☐ 22.901(d) - Alternative technologies and auxiliary services
- ☐ 23 - International Fixed Public Radiocommunication services
- ☒ 24 - Personal Communications Services
- ☐ 74 Subpart H - Low Power Auxiliary Stations
- ☐ 80 - Stations in the Maritime Services
- ☐ 80 Subpart E - General Technical Standards
- ☐ 80 Subpart F - Equipment Authorization for Compulsory Ships
- ☐ 80 Subpart K - Private Coast Stations and Marine Utility Stations
- ☐ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- ☐ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- ☐ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- ☐ 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- ☐ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- ☐ 80 Subpart X - Voluntary Radio Installations
- ☐ 87 - Aviation Services
- ☐ 90 - Private Land Mobile Radio Services
- ☐ 94 - Private Operational-Fixed Microwave Service
- ☐ 95 Subpart A - General Mobile Radio Service (GMRS)
- ☐ 95 Subpart C - Radio Control (R/C) Radio Service
- ☐ 95 Subpart D - Citizens Band (CB) Radio Service
- ☐ 95 Subpart E - Family Radio Service
- ☐ 95 Subpart F - Interactive Video and Data Service (IVDS)
- ☐ 97 - Amateur Radio Service
- ☐ 101 - Fixed Microwave Services

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GENERAL INFORMATION

1. Prior to testing, the deviation for audio modulation and each of the respective SAT + ST tones were set as close as possible to the required limit.
2. Except for audio modulation, which was applied externally, Wideband Data SAT, ST and all other tones and operational modes were provided by a test control unit incorporating appropriate software. Worst case repetition rate for Wideband Data was 10 kb/s.
3. Spurious radiation was measured at three (3) meters.
4. The two cellular frequency bands are available to the user automatically. Please refer to the manual contained in the documentation.
5. The normal modes of modulation are:
 - ☒ (a) VOICE
 - ☒ (b) WIDEBAND DATA
 - ☒ (c) SAT
 - ☒ (d) ST
 - ☒ (e) SAT + VOICE
 - ☒ (f) SAT + DTMF
 - ☐ (g) CDMA
 - ☒ (h) TDMA
 - ☐ (i) NAMPS VOICE
 - ☐ (j) NAMPS DSAT
 - ☐ (k) NAMPS ST
 - ☐ (l) NAMPS VOICE + DSAT

PAGE NO.

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STANDARD TEST CONDITIONS
and
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

GUIDES:

This device was tested using the following Guide(s):

TIA/EIA IS-137-A-1-1997

PAGE NO. 8 of 72.

NAME OF TEST: Carrier Output Power (Conducted)

SPECIFICATION: 47 CFR 2.1046(a)

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the unmodulated output power was measured by means of an R. F. Power Meter.
2. Measurement accuracy is $\pm 3\%$.

MEASUREMENT RESULTS

NOMINAL, MHz	CHANNEL	R. F. POWER, WATTS	
		Lo	Hi
AMPS MODE:			
824.040	991	0.006	0.16
836.400	380	0.006	0.16
848.970	799	0.006	0.16
TDMA MODE:			
824.73	991	0.006	0.62
836.40	380	0.006	0.62
848.19	799	0.006	0.62
PCS-TDMA MODE:			
1851.25	2	339μ	0.18
1880.00	600	339μ	0.18
1908.75	1175	339μ	0.18

SUPERVISED BY:



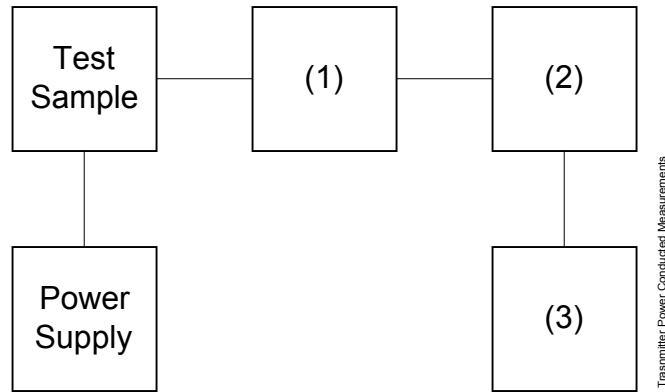
William H. Graff, Director
of Engineering

PAGE NO.

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TRANSMITTER POWER CONDUCTED MEASUREMENTS

TEST 1: R. F. POWER OUTPUT
 TEST 2: FREQUENCY STABILITY



Asset	Description (as applicable)	s/n
(1)	<u>COAXIAL ATTENUATOR</u>	
i00122	Narda 766-10	7802
i00123	Narda 766-10	7802A
i00069	Bird 8329 (30 dB)	1006
i00113	Sierra 661A-3D	1059
(2)	<u>POWER METERS</u>	
i00014	HP 435A	1733A05836
i00039	HP 436A	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(3)	<u>FREQUENCY COUNTER</u>	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A FREQUENCY MODE	2105A01087

PAGE NO. 10 of 72.

NAME OF TEST: R. F. Power Output (Radiated)

SPECIFICATION: 47 CFR 2.1046(a)

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE (RADIATED)

1. The EUT was placed on an open-field site and its radiated field strength at a known distance was measured by means of a spectrum analyzer. Equivalent loading was calculated from the equation $P_t = ((E \times R)^2 / 49.2)$ watts, where $R = 3m$.
2. Measurement accuracy is ± 1.5 dB.

MEASUREMENT RESULTS

g0020247: 2000-Feb-29 Tue 14:14:00

STATE: 2:High Power AMPS MODE

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV/m	CF, dB	ERP, dBm	ERP, Watts
824.040000	824.048000	82.41	36.4	21.4	0.14
836.400000	836.403000	82.85	36.6	22.1	0.16
848.970000	848.973000	83.89	36.79	23.3	0.21

g0020246: 2000-Feb-29 Tue 09:14:00

STATE: 2:High Power TDMA MODE

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV/m	CF, dB	ERP, dBm	ERP, Watts
824.040000	824.048000	86.87	36.4	25.9	0.39
836.400000	836.410000	88.63	36.6	27.9	0.62
848.970000	848.978000	89.36	36.79	28.8	0.76

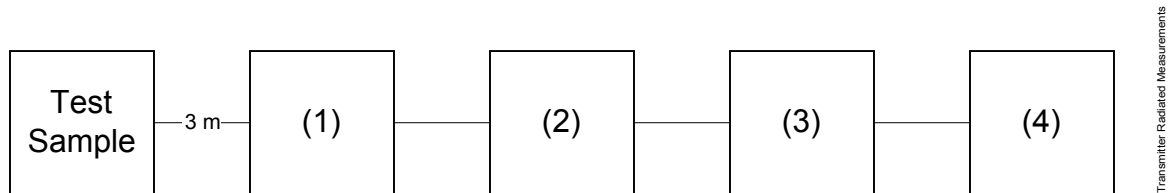
g0030081: 2000-Mar-01 Wed 11:13:00

STATE: 2:High Power TDMA-PCS MODE

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV/m	CF, dB	EIRP, dBm	EIRP, Watts
1850.040000	1850.063000	86.43	31.67	22.9	0.19
1879.980000	1880.000000	86.4	31.24	22.4	0.17
1909.920000	1909.943000	84.64	31.25	20.7	0.12

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TRANSMITTER RADIATED MEASUREMENTS

Asset	Description (as applicable)	s/n
(1)	<u>TRANSDUCER</u>	
i00091	Emco 3115	001469
i00089	Apriel Log Periodic	001500
(2)	<u>HIGH PASS FILTER</u>	
i00	Narda μ PAD (In-Band Only)	
i00	Trilithic (Out-Of-Band Only)	
(3)	<u>PREAMP</u>	
i00028	HP 8449 (+30 dB)	2749A00121
(4)	<u>SPECTRUM ANALYZER</u>	
i00048	HP 8566B	2511A01467
i00043	HP 8558B	2004A02076
i00057	HP 8557A	1531A00191
i00029	HP 8563E	3213A00104

PAGE NO. 12 of 72.
NAME OF TEST: Audio Frequency Response
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: As indicated on page 7
TEST EQUIPMENT: As per previous page

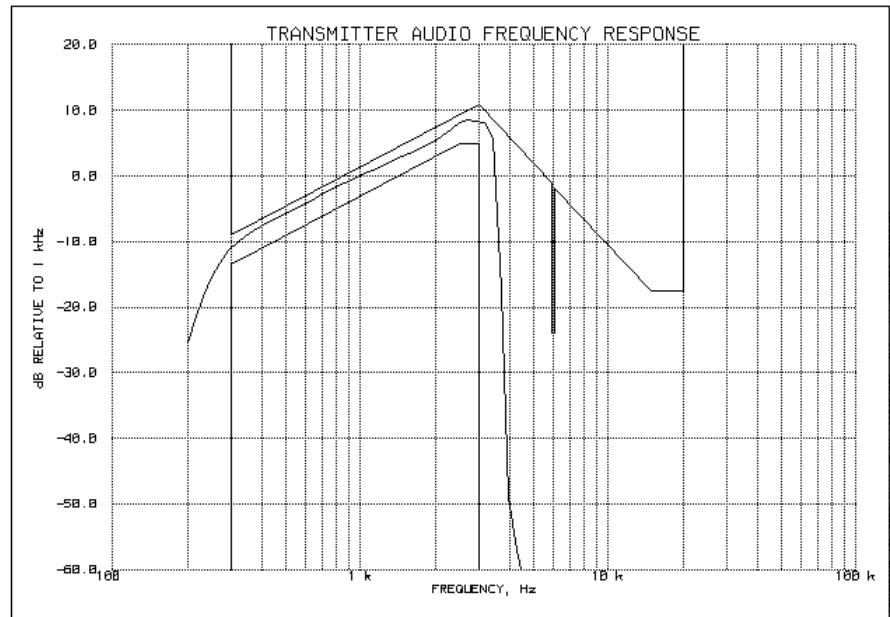
MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. The audio signal generator was connected to the audio input circuit/microphone of the EUT.
3. The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.
4. With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.
5. The response in dB relative to 1 kHz was then measured, using the HP 8901A Modulation Analyzer.
6. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

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NAME OF TEST: Audio Frequency Response
g0030014: 2000-Mar-10 Fri 07:50:00
STATE: 0:General



SUPERVISED BY:

William H. Graff, Director
of Engineering

PAGE NO. 14 of 72.
NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: As indicated on page 7
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

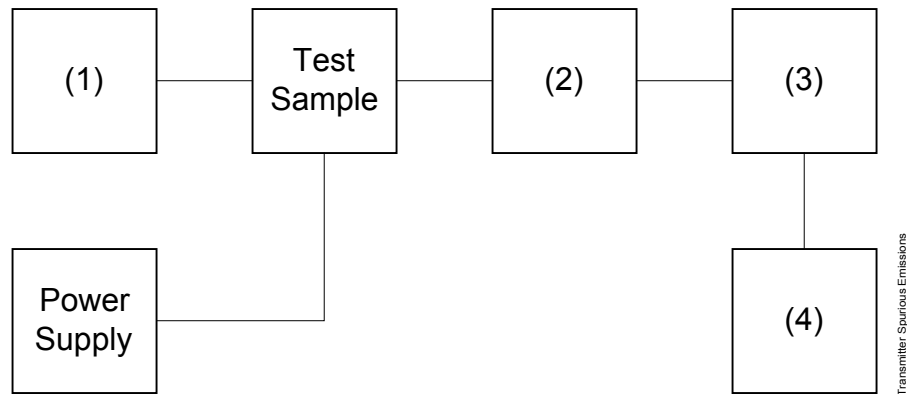
1. The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.
2. The audio output was connected at the output to the modulated stage.
3. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

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TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS

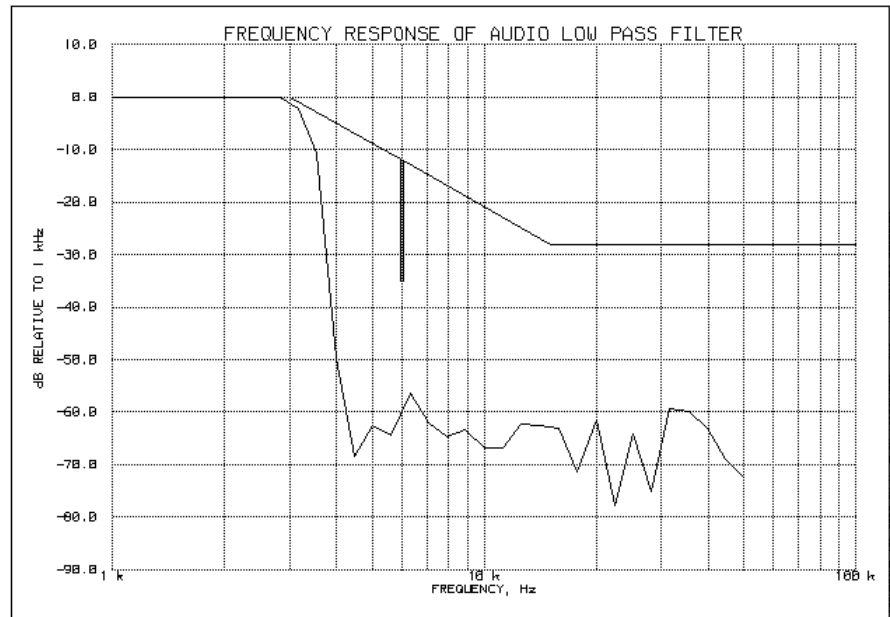


Asset Description (as applicable)	s/n
(1) <u>AUDIO OSCILLATOR/GENERATOR</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00012 HP 3312A	1432A11250
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 Narda 766-10	7802
i00123 Narda 766-10	7802A
i00069 Bird 8329 (30 dB)	1006
i00113 Sierra 661A-3D	1059
(3) <u>FILTERS; NOTCH, HP, LP, BP</u>	
i00126 Eagle TNF-1	100-250
i00125 Eagle TNF-1	50-60
i00124 Eagle TNF-1	250-850
(4) <u>SPECTRUM ANALYZER</u>	
i00048 HP 8566B	2511A01467
i00029 HP 8563E	3213A00104

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NAME OF TEST: Audio Low Pass Filter (Voice Input)
g0030021: 2000-Mar-10 Fri 09:36:00
STATE: 0:General



SUPERVISED BY:

William H. Graff, Director
of Engineering

PAGE NO. 17 of 72.

NAME OF TEST: Modulation Limiting

SPECIFICATION: 47 CFR 2.1047(b)

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The audio signal generator was connected to the audio input circuit/microphone of the EUT as for Frequency Response of the Audio Modulating Circuit.
2. The modulation response was measured for each of three tones (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.
3. The audio input level was varied from 30% modulation (± 3.6 kHz deviation) to at least 20 dB higher than the saturation point.
4. Measurements were performed for both negative and positive modulation and the respective results were recorded.
5. MEASUREMENT RESULTS ATTACHED FOR:

COMPANDER ON:

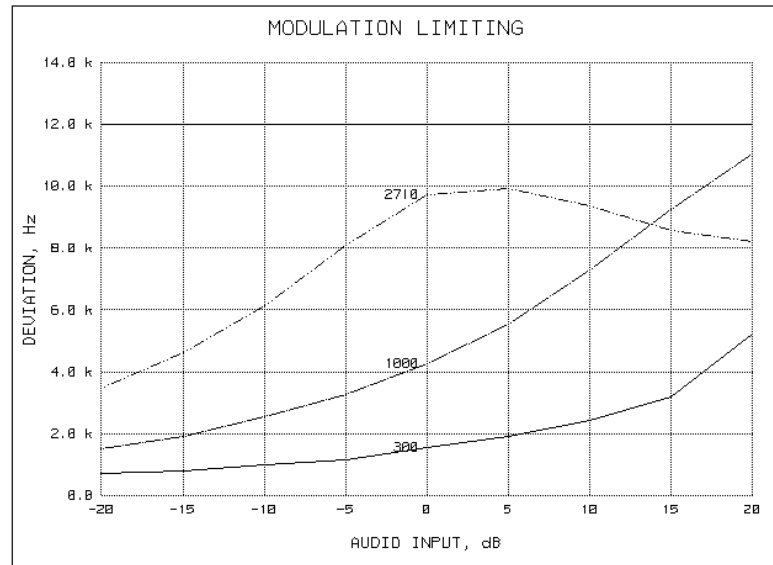
 x VOICE
 x VOICE + SAT

PAGE NO.

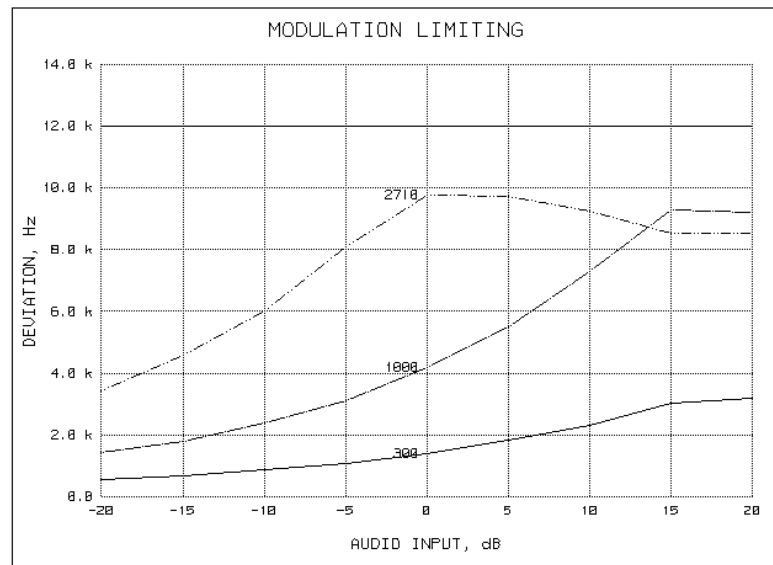
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NAME OF TEST: Modulation Limiting
 g0030019: 2000-Mar-10 Fri 08:40:00
 STATE: 0:General VOICE ONLY

Positive
 Peaks:



Negative
 Peaks:



SUPERVISED BY:

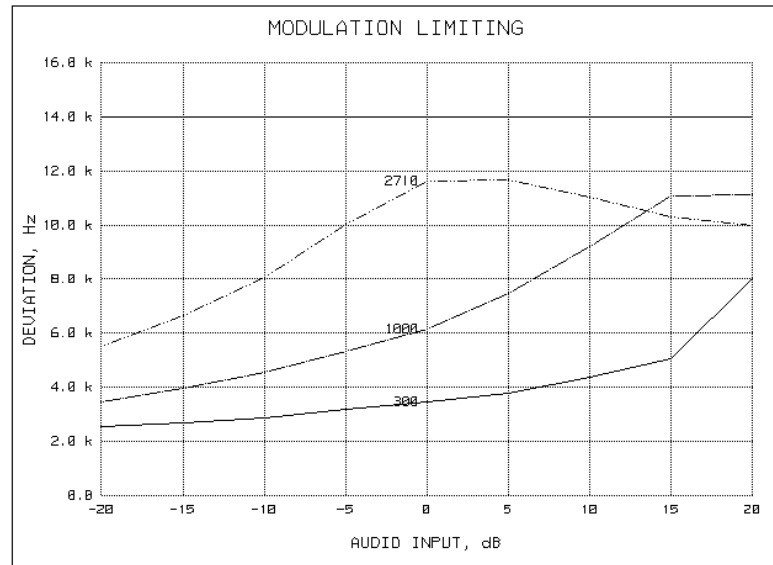
William H. Graff, Director
 of Engineering

PAGE NO.

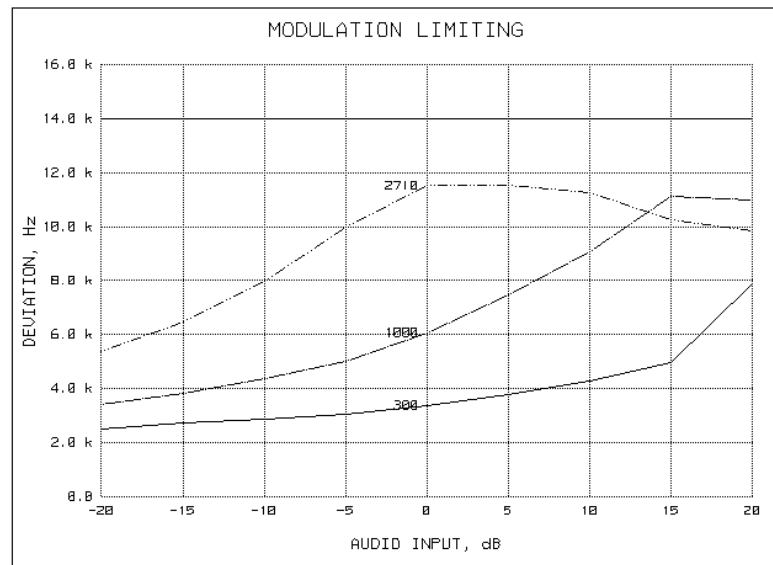
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NAME OF TEST: Modulation Limiting
 g0030018: 2000-Mar-10 Fri 08:28:00
 STATE: 0:General VOICE + SAT

Positive
 Peaks:



Negative
 Peaks:



SUPERVISED BY:

William H. Graff, Director
 of Engineering

PAGE NO. 20 of 72.
NAME OF TEST: Measurement Of Maximum Deviation
GUIDE: As indicated on page 7
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

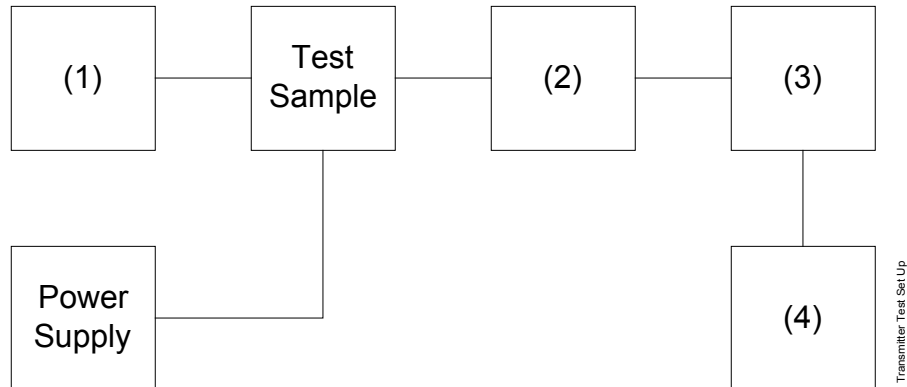
1. The presentation of tones was obtained by attaching the HP 8903A Oscilloscope to the Modulation Output of the HP 8901 Modulation Analyzer.
2. The EUT was modulated by an HP 8903 Audio Analyzer and/or internally generated signals.
3. Maximum deviation measurements were recorded for the various configurations.
4. MEASUREMENT RESULTS: ATTACHED SUMMARY FOR DEVIATION

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TRANSMITTER TEST SET-UP

TEST A. MODULATION CAPABILITY/DISTORTION
 TEST B. AUDIO FREQUENCY RESPONSE
 TEST C. HUM AND NOISE LEVEL
 TEST D. RESPONSE OF LOW PASS FILTER
 TEST E. MODULATION LIMITING



Asset	Description (as applicable)	s/n
(1)	<u>Audio Oscillator</u>	
i00010	HP 204D	1105A04683
i00017	HP 8903A	2216A01753
i00118	HP 33120A	US36002064
(2)	<u>COAXIAL ATTENUATOR</u>	
i00122	NARDA 766-10	7802
i00123	NARDA 766-10	7802A
i00113	SIERRA 661A-3D	1059
i00069	BIRD 8329 (30 dB)	10066
(3)	<u>MODULATION ANALYZER</u>	
i00020	HP 8901A	2105A01087
(4)	<u>AUDIO ANALYZER</u>	
i00017	HP 8903A	2216A01753

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MEASUREMENT SUMMARY: Measurement Of Maximum Deviation

MODULATION	LIMIT, kHz	DEVIATION, MHz
(a) Voice	$\geq 10.8 \text{ \& } \leq 13.2$	10.8
(b) Wideband Data	$\geq 7.2 \text{ \& } \leq 8.8$	8.5
(c) SAT	$\geq 1.8 \text{ \& } \leq 2.2$	2.2
(d) ST	$\geq 7.2 \text{ \& } \leq 8.8$	8.4
(e) SAT + VOICE	N/A	12.3
(f) SAT + DTMF	N/A	11.2
(i) NAMPS VOICE	N/A	N/A
(j) NAMPS DSAT	N/A	N/A
(k) NAMPS ST	N/A	N/A
(l) NAMPS VOICE	N/A	N/A

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NAME OF TEST: Emission Masks (Occupied Bandwidth)

SPECIFICATION: 47 CFR 2.1049(c)(1), 22

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for ± 2.5 kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.
3. For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.
4. The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.
5. MEASUREMENT RESULTS: ATTACHED

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MEASUREMENT SUMMARY: Emission Masks (Occupied Bandwidth)

MODULATION	MEASURED DEVIATION ±kHz (HP 8901A)	LIMIT ±kHz	B/W @-26 dB PLOTS, kHz
NONE	0.0	0.0	0.0
VOICE	10.8	≥ 10.8 & ≤ 13.2	26
WIDEBAND DATA	8.5	≥ 7.2 & ≤ 8.8	40
SAT + VOICE	12.3	N/A	28
SAT + DTMF	11.2	N/A	24
CDMA	N/A	N/A	N/A
TDMA	N/A	N/A	25
NAMPS	N/A	N/A	N/A

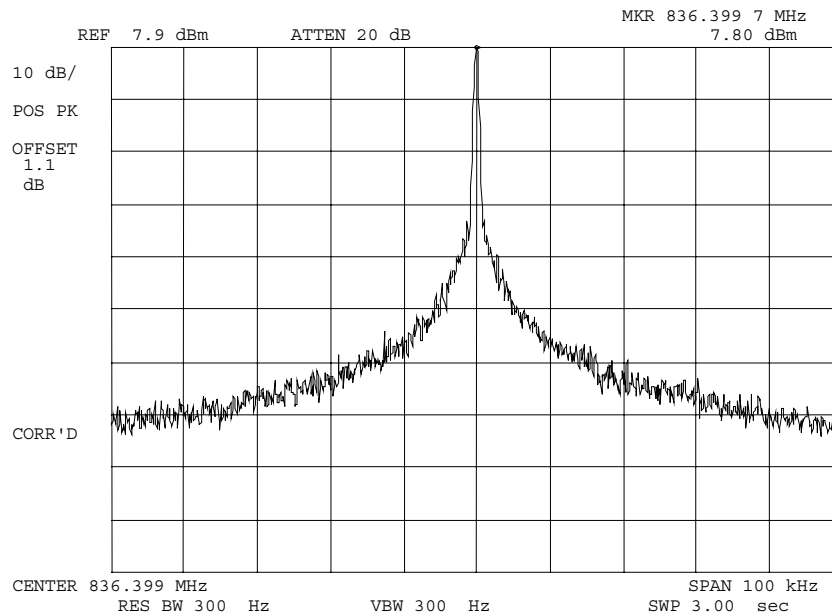
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030096: 2000-Mar-10 Fri 12:07:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
NONE

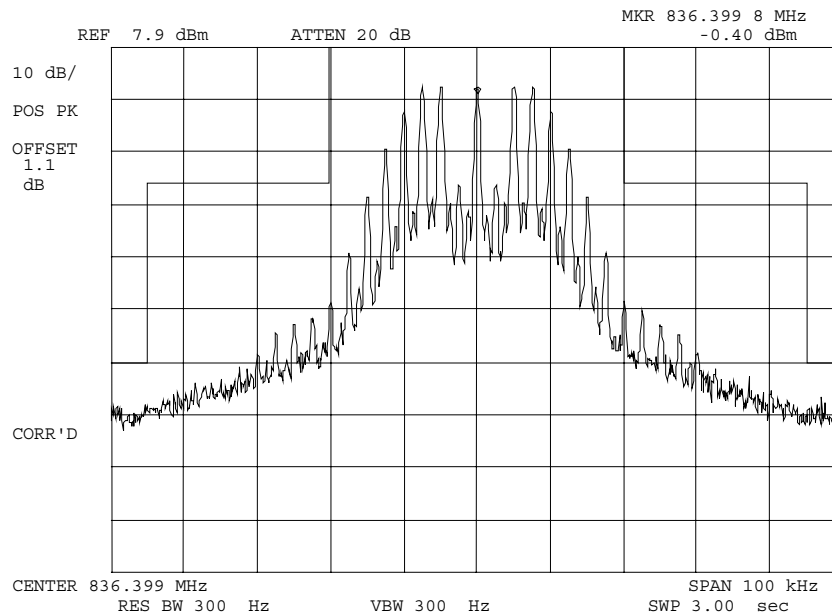
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030098: 2000-Mar-10 Fri 12:21:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 VOICE: 2500 Hz SINE WAVE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

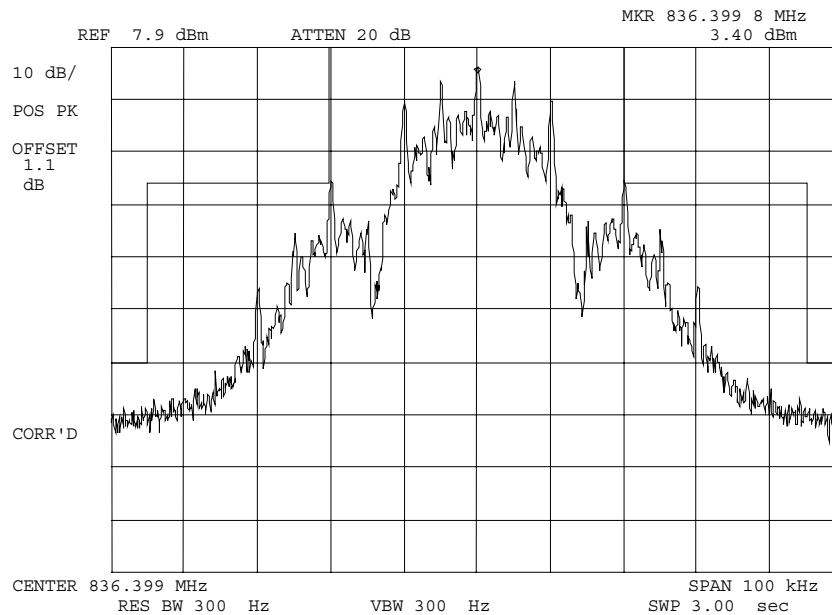
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030106: 2000-Mar-10 Fri 12:42:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
WBD
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

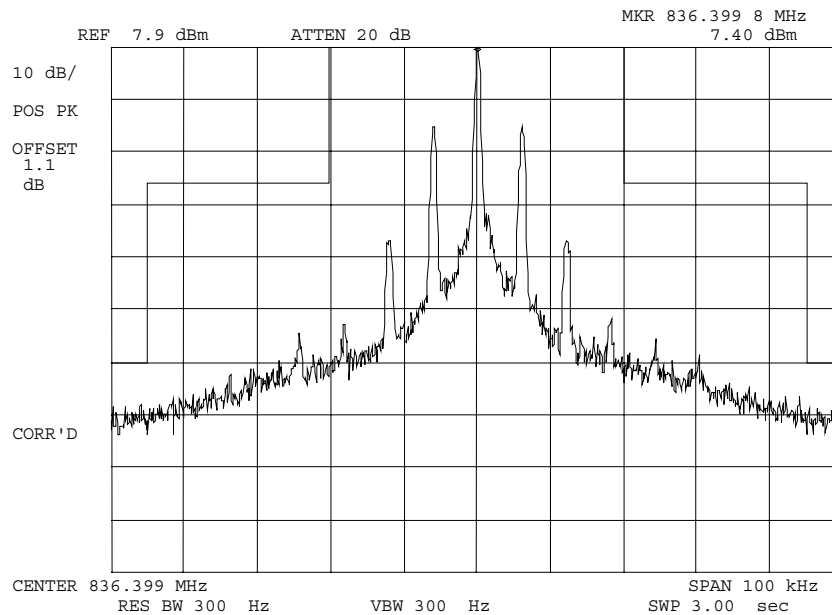
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030102: 2000-Mar-10 Fri 12:32:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

SAT

MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

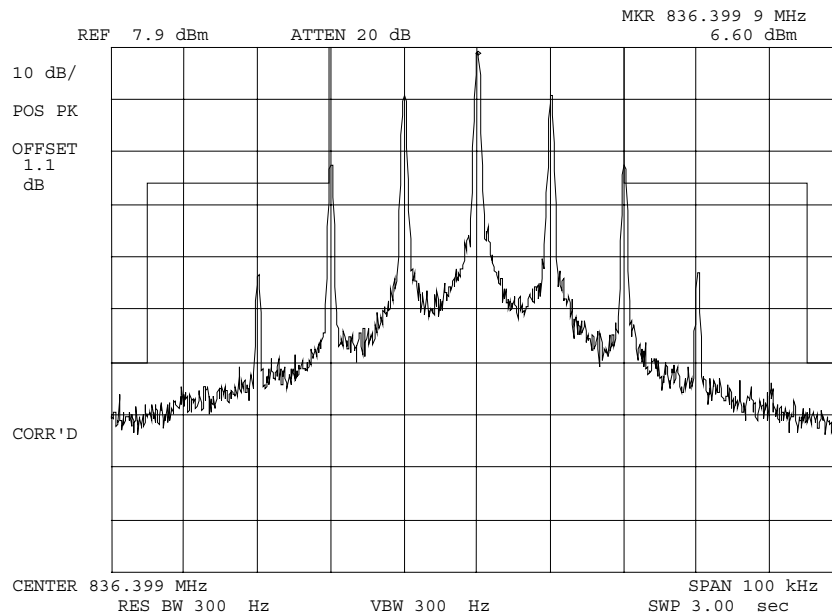
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030105: 2000-Mar-10 Fri 12:39:00
STATE: 1:Low Power



POWER:

LOW

MODULATION:

ST

MASK: AMPS CELLULAR,
F3E/F3D w/LPF

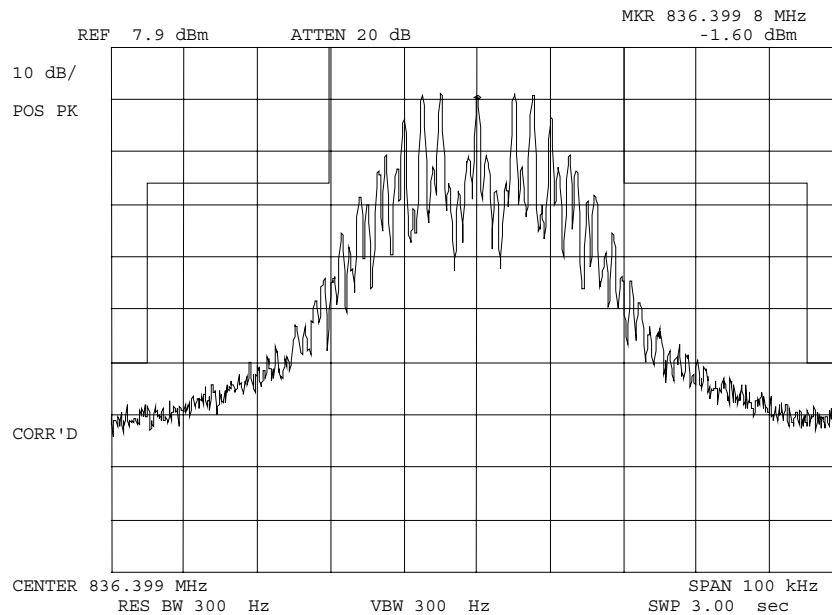
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030099: 2000-Mar-10 Fri 12:25:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
SAT+VOICE
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

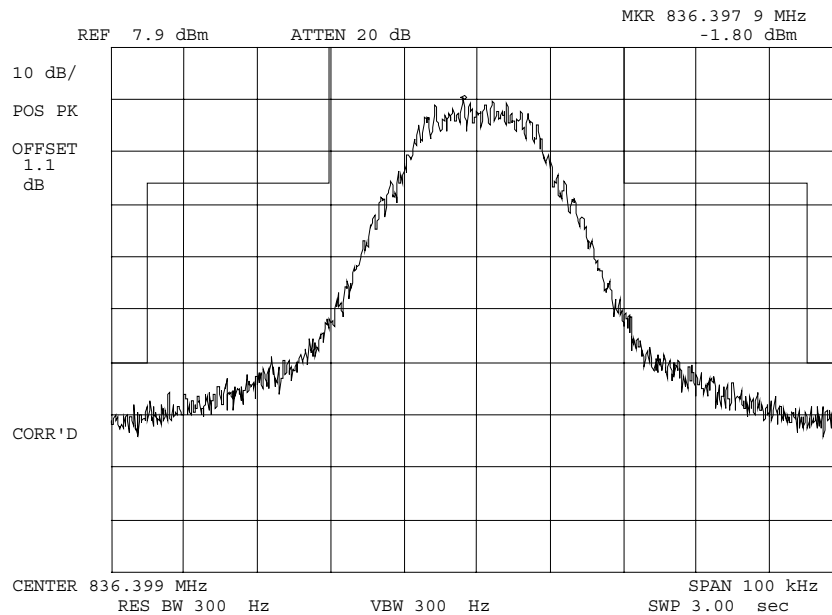
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030103: 2000-Mar-10 Fri 12:35:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

SAT+DTMF

MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

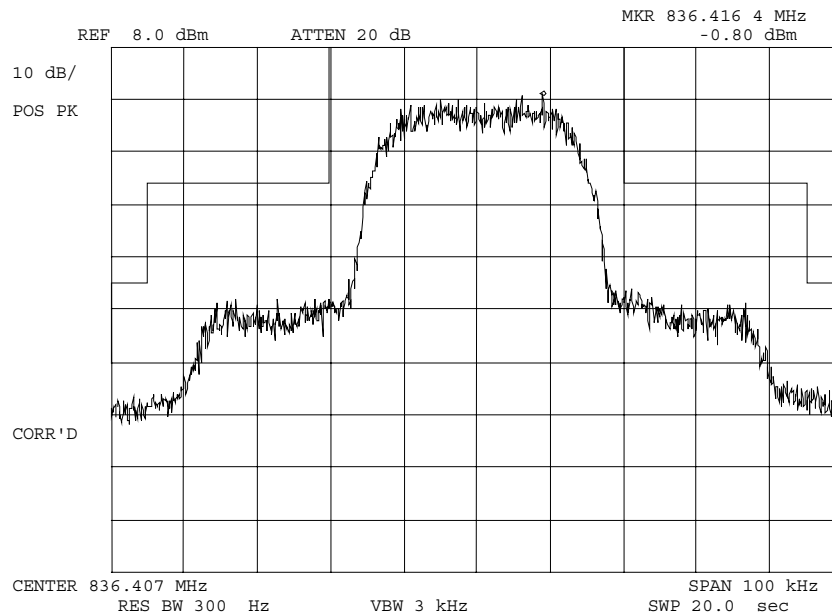
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030119: 2000-Mar-10 Fri 14:40:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 TDMA AMPS
 MASK: AMPS CELLULAR, F1D,
 DATA

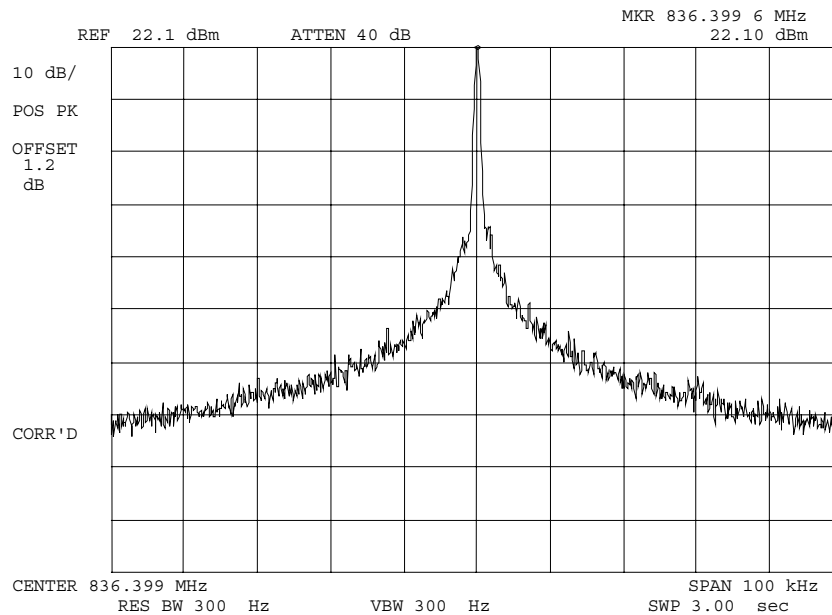
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030095: 2000-Mar-10 Fri 12:05:00
STATE: 2:High Power



POWER: HIGH
MODULATION: NONE

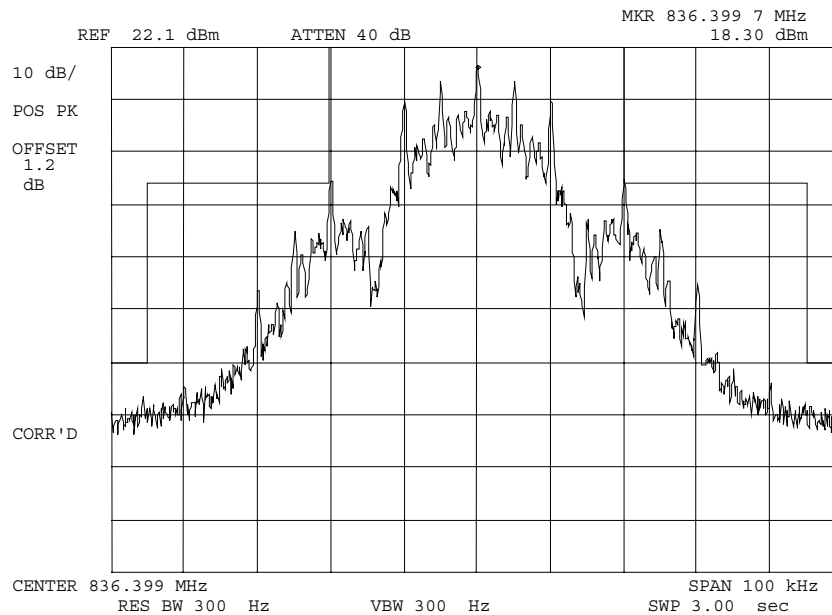
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030115: 2000-Mar-10 Fri 13:31:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 WBD
 AMPS CELLULAR, F3E/F3D
 W/LPW

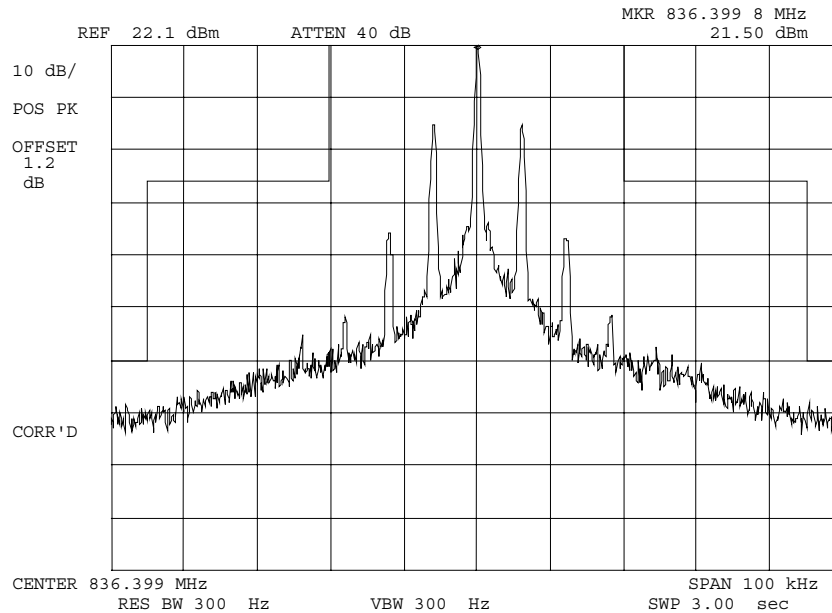
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030101: 2000-Mar-10 Fri 12:31:00
STATE: 2:High Power



POWER: HIGH
MODULATION: SAT
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

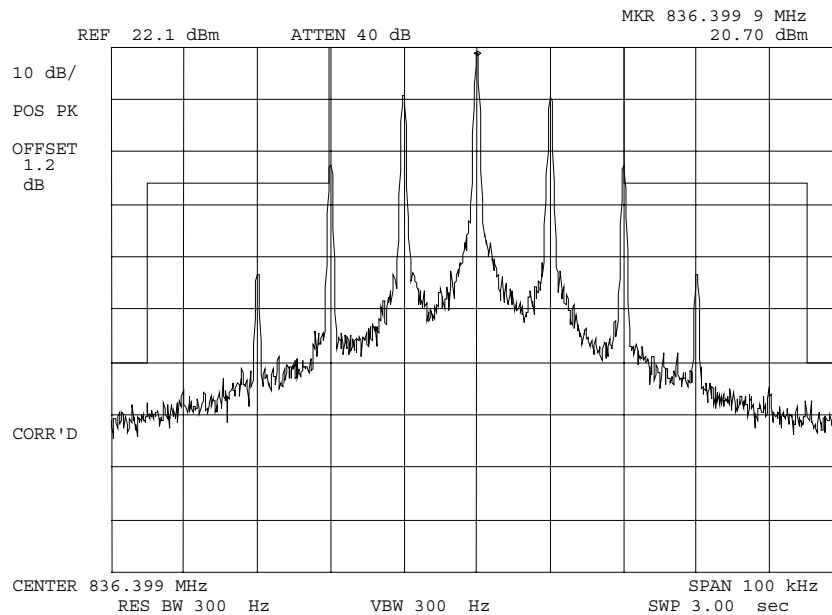
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030104: 2000-Mar-10 Fri 12:38:00
STATE: 2:High Power



POWER:

HIGH

MODULATION:

ST

MASK: AMPS CELLULAR,
F3E/F3D w/LPF

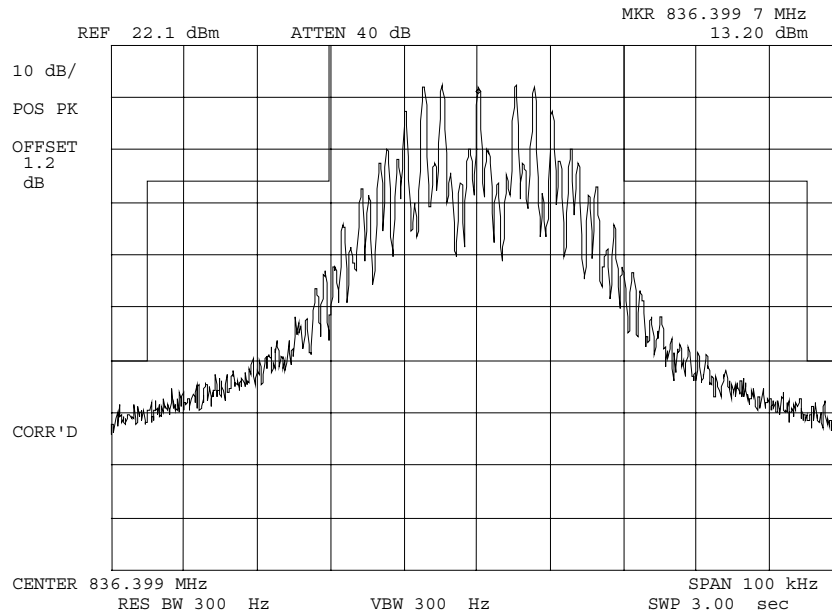
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030100: 2000-Mar-10 Fri 12:26:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 SAT+VOICE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

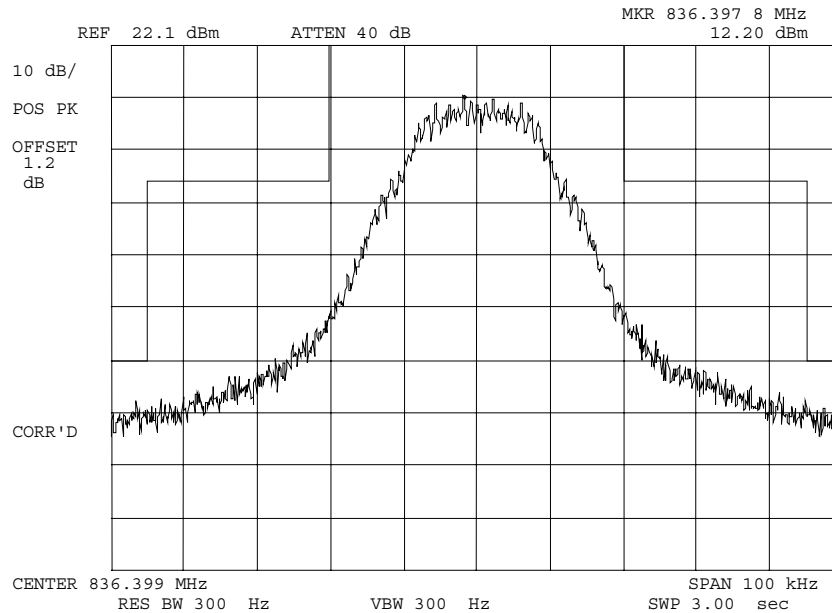
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030116: 2000-Mar-10 Fri 13:35:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 SAT+DTMF
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

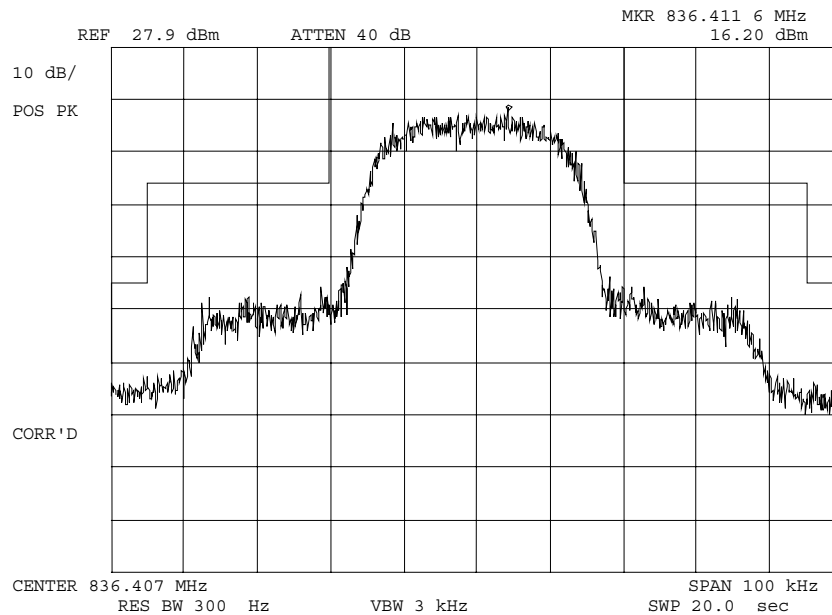
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030118: 2000-Mar-10 Fri 14:31:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
TDMA AMPS
MASK: AMPS CELLULAR, F1D,
DATA

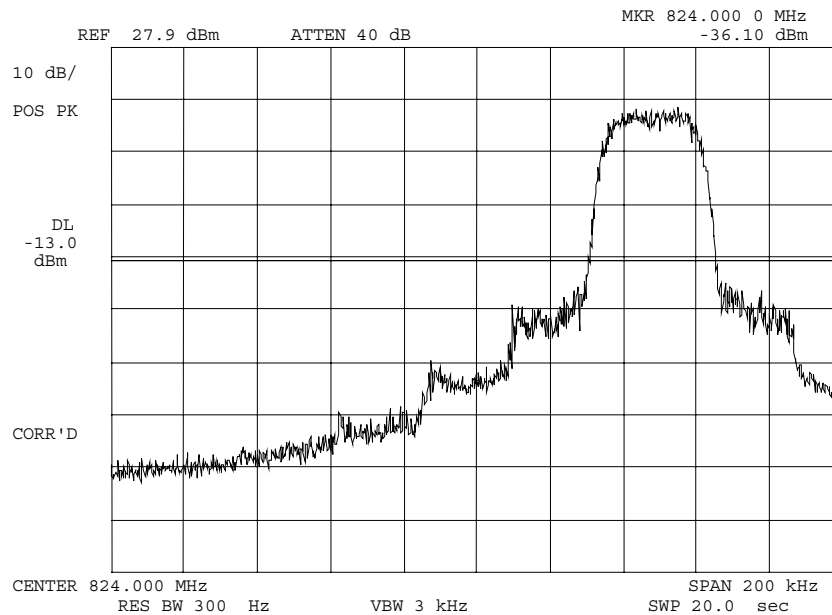
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030120: 2000-Mar-10 Fri 15:00:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
TDMA AMPS
LOWER BANDEDGE CHANNEL 991

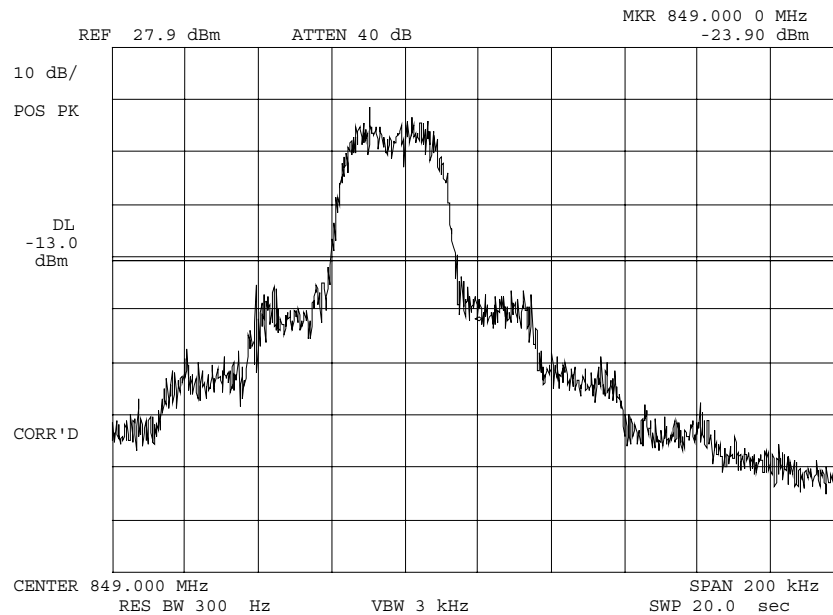
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030121: 2000-Mar-10 Fri 15:05:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA AMPS
 UPPER BANDEDGE CHANNEL 799

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NAME OF TEST: Transmitter Conducted Measurements

SPECIFICATION: 47 CFR 2.1051: Unwanted (spurious) Emissions
2.1049(c), 24.238(b): Occupied Bandwidth
24: Emissions at Band Edges

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page with the Spectrum Analyzer connected.
2. The low and high channels for all RF powers within the designated frequency block(s) were measured.
3. MEASUREMENT RESULTS: ATTACHED

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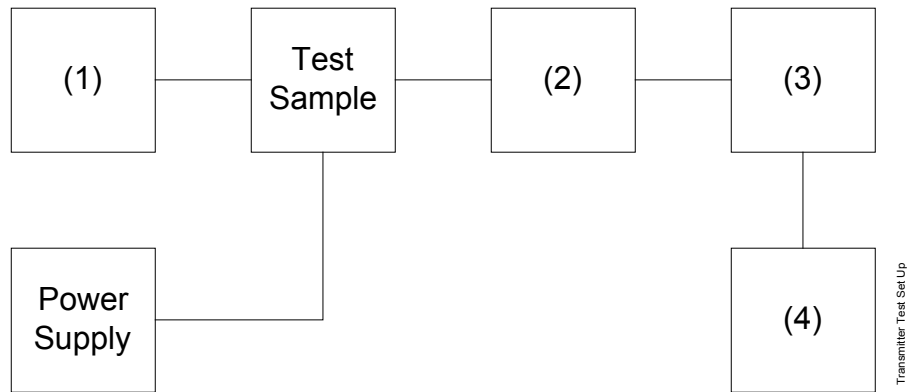
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TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS

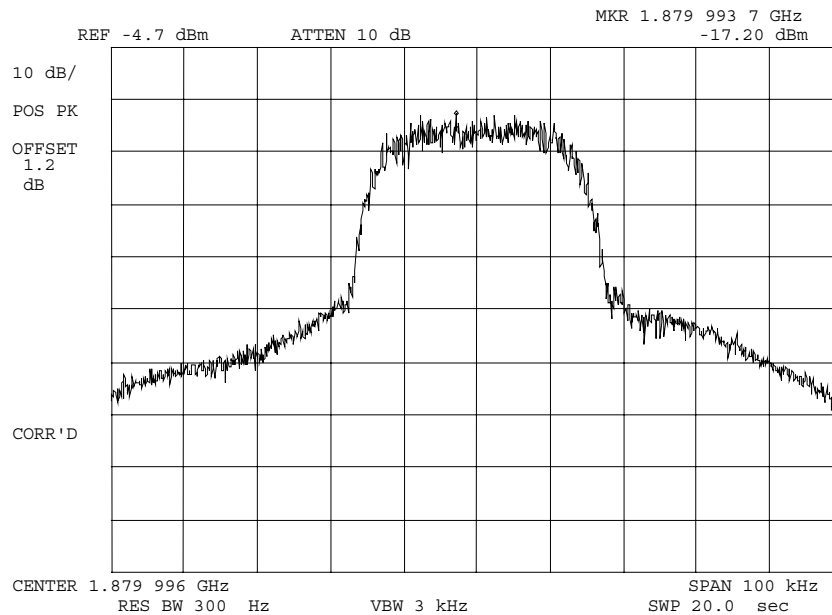


Asset Description (as applicable)	s/n
(1) <u>AUDIO OSCILLATOR/GENERATOR</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00012 HP 3312A	1432A11250
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 Narda 766-10	7802
i00123 Narda 766-10	7802A
i00069 Bird 8329 (30 dB)	1006
i00113 Sierra 661A-3D	1059
(3) <u>FILTERS; NOTCH, HP, LP, BP</u>	
i00126 Eagle TNF-1	100-250
i00125 Eagle TNF-1	50-60
i00124 Eagle TNF-1	250-850
(4) <u>SPECTRUM ANALYZER</u>	
i00048 HP 8566B	2511A01467
i00029 HP 8563E	3213A00104

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030124: 2000-Mar-10 Fri 15:32:00
STATE: 1:Low Power



POWER:
MODULATION:

LOW
TDMA PCS

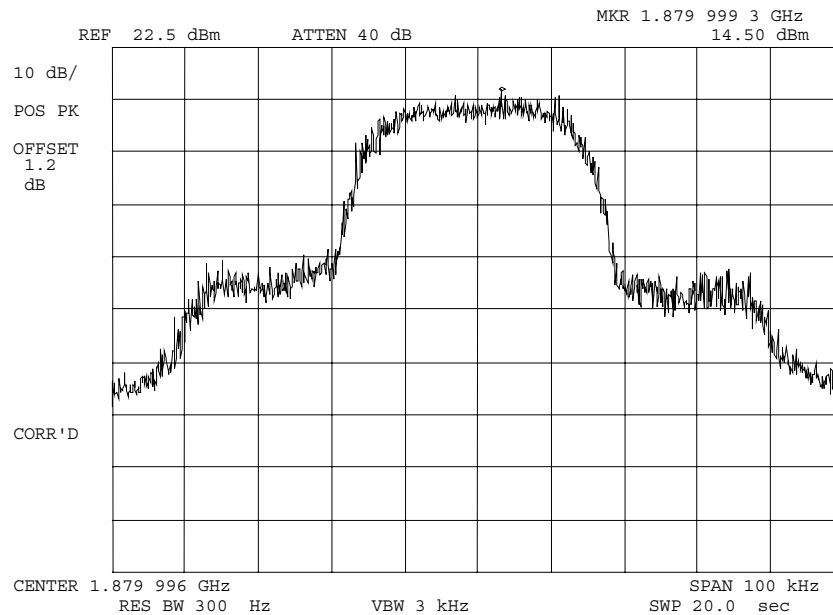
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030122: 2000-Mar-10 Fri 15:18:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA PCS

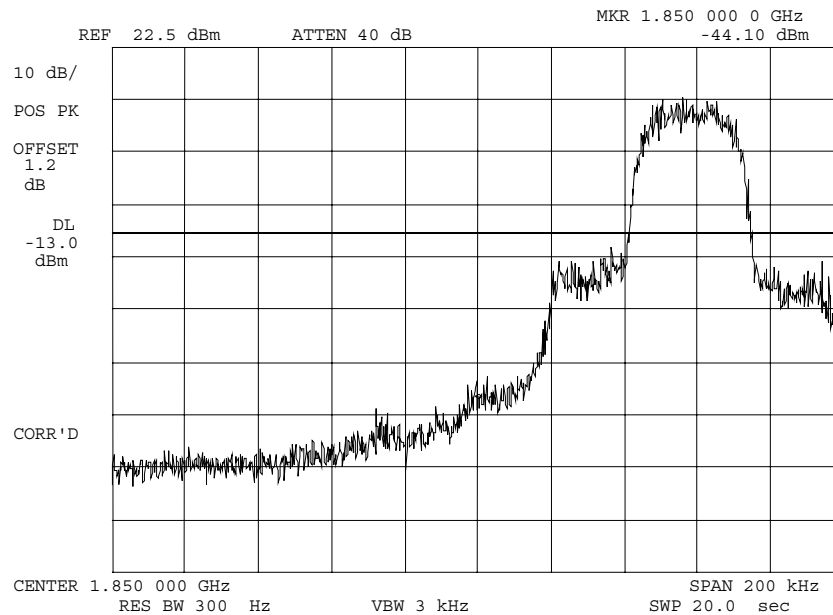
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030125: 2000-Mar-10 Fri 15:36:00
STATE: 1:Low Power



POWER:
MODULATION:

High
TDMA PCS
LOWER BANDEDGE CHANNEL 02

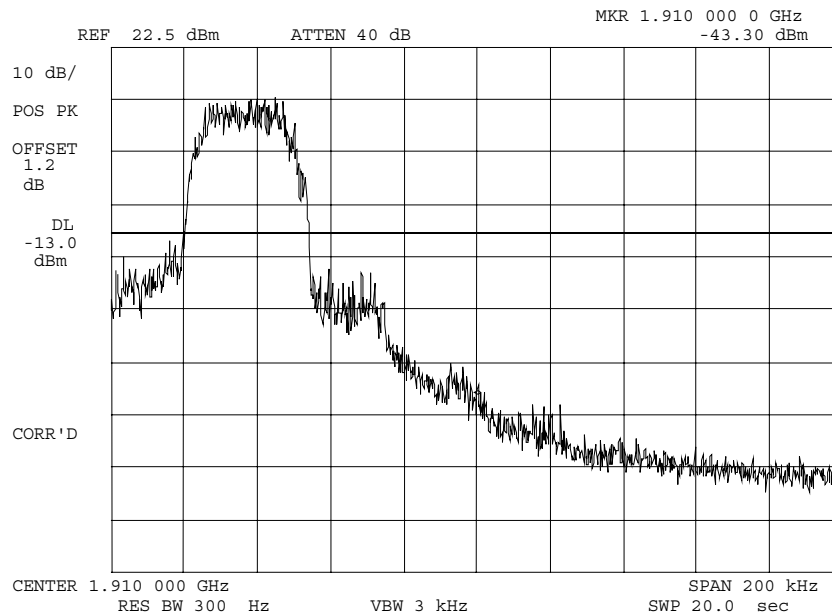
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030126: 2000-Mar-10 Fri 15:40:00
 STATE: 1:Low Power



POWER:
 MODULATION:

High
 TDMA PCS
 UPPER BANDEDGE CHANNEL 1998

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NAME OF TEST: Emission Requirements -
Worst Case Modulation & Wideband Data

SPECIFICATION: 47 CFR 22.917

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a spectrum analyzer. The unmodulated carrier was set for 0 dB reference level.
2. A notch filter was introduced to reduce or eliminate any spectrum analyzer internally generated spurious for measurements of the harmonics and the carrier level.
3. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
4. Measurements were made on channels 380, 799 and 991. The equipment was first modulated for the Worst Case Modulation, then for Wideband Data (F8W, F1D).
5. All other spurious emissions over the range of 0 the beyond the 10th harmonic (10 GHz) were 20 dB or more below the limit
6. The data presented here is for the Worst Case.
7. MEASUREMENT RESULTS: ATTACHED

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MEASUREMENT SUMMARY: Emission Requirements -
Worst Case Modulation

WORST CASE MODULATION = VOICE +_SAT

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F0 + 20 kHz to F0 + 45 kHz	≤ -26	≤ -51	≤ -53
F0 + 45 kHz to 2 nd Harmonic	≤ -60 or $43 + 10 \log P$	≤ -69	≤ -69
2 nd to 10 th	$(\leq -13 \text{ dBm})$	≤ -50	≤ -52.6

MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤ -80	≤ -86.4	≤ -87

MEASUREMENT RESULTS = ATTACHED PLOTS

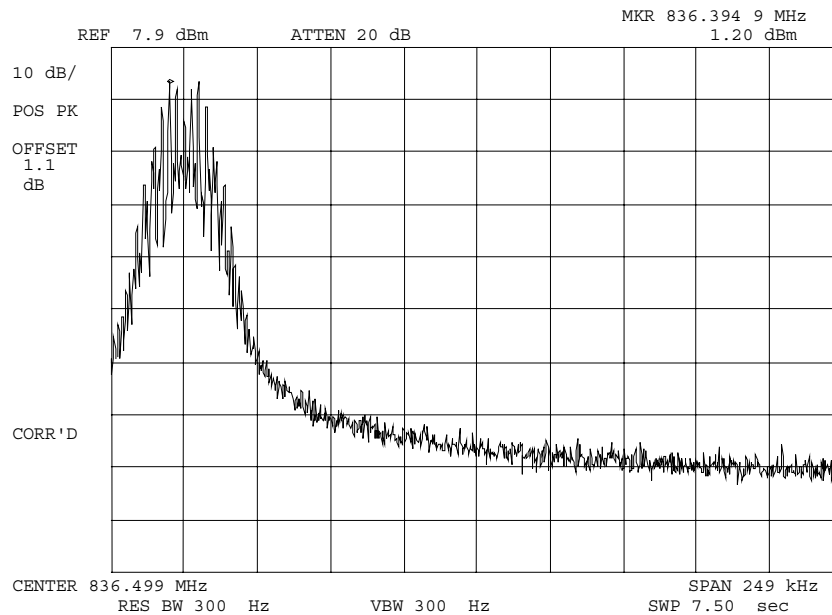
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030112: 2000-Mar-10 Fri 13:05:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

SAT+VOICE

OFFSET OCCUPIED BANDWIDTH

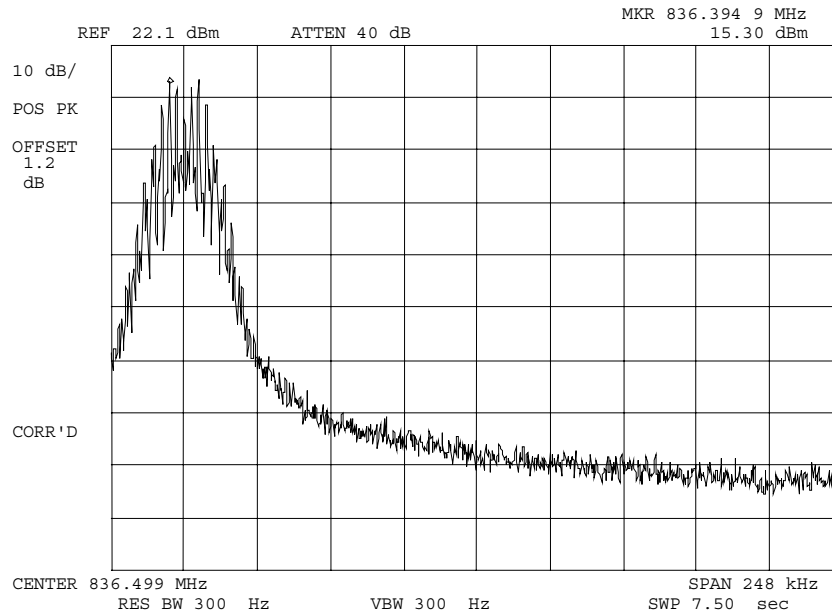
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030111: 2000-Mar-10 Fri 13:03:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
SAT+VOICE
OFFSET OCCUPIED BANDWIDTH

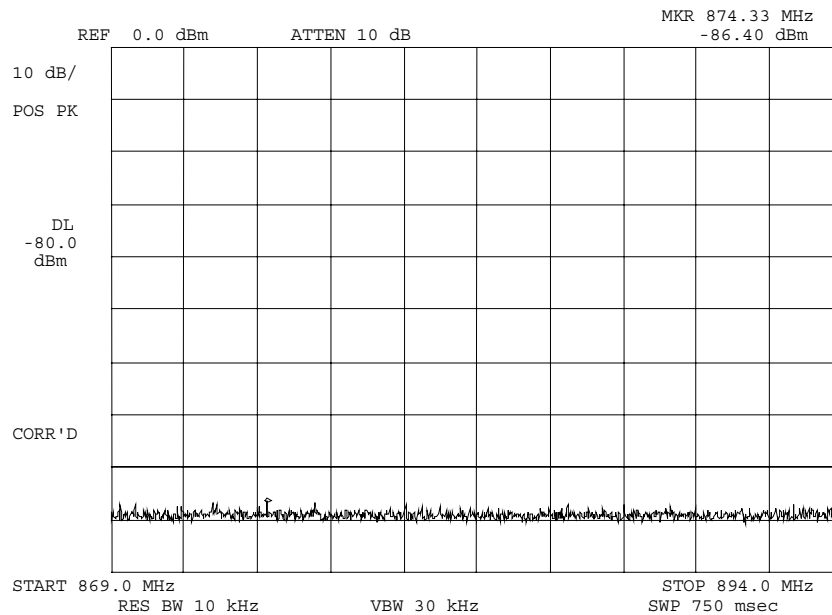
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030113: 2000-Mar-10 Fri 13:06:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

ANY

TX SPURS IN RX CRITICAL
 BAND

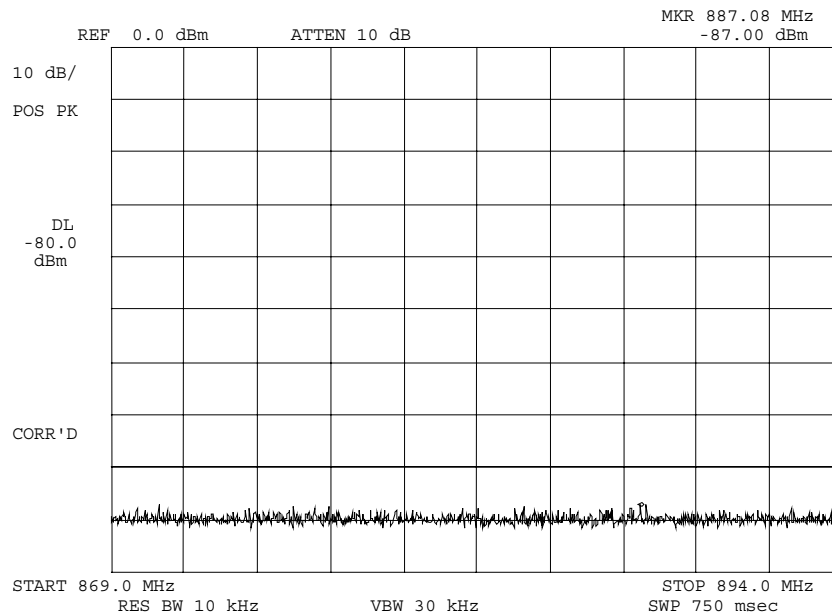
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030114: 2000-Mar-10 Fri 13:07:00
 STATE: 2:High Power



POWER:

HIGH

MODULATION:

ANY

TX SPURS IN RX CRITICAL
 BAND

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MEASUREMENT SUMMARY: Emission Requirements -
Wideband Data (F1D, 10 kb/s)

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F0 + 20 kHz to F0 + 45 kHz	≤-26	≤-36	≤-37
F0 + 45 kHz to F0 + 90 kHz	≤-45	≤-69	≤-72
F0 + 90 kHz to 2 nd Harmonic	≤-60 (≤-13 dBm)	≤-40	≤-39.5
2 nd to 10 th	(≤-13 dBm)	≤-55	≤-52.6

MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤-80	≤-86.4	≤-87

MEASUREMENT RESULTS = ATTACHED PLOTS

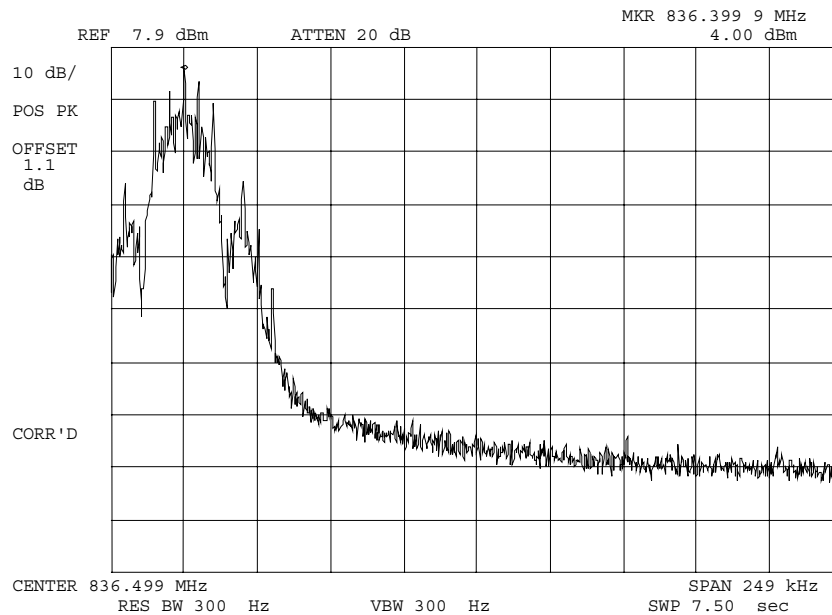
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030108: 2000-Mar-10 Fri 12:56:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

WBD

OFFSET OCCUPIED BANDWIDTH

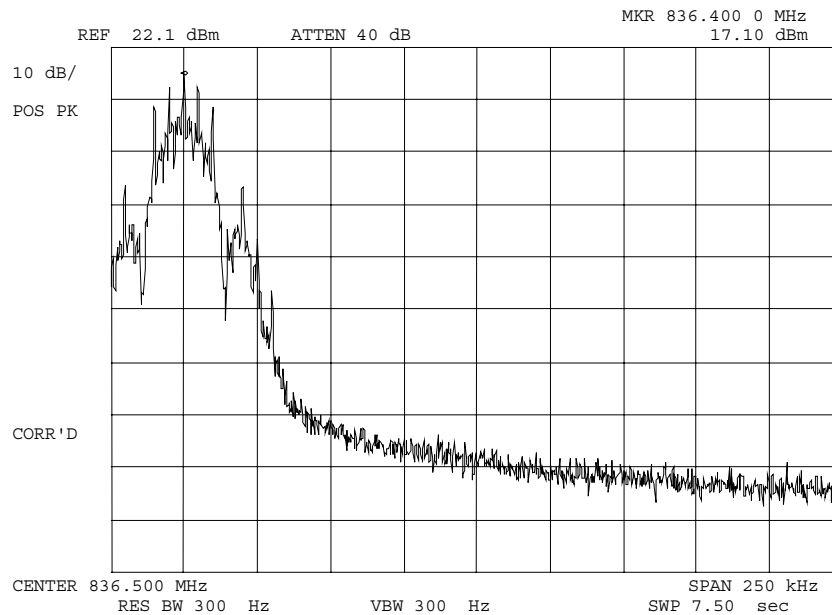
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030107: 2000-Mar-10 Fri 12:52:00
STATE: 2:High Power



POWER:

HIGH

MODULATION:

WBD

OFFSET OCCUPIED BANDWIDTH

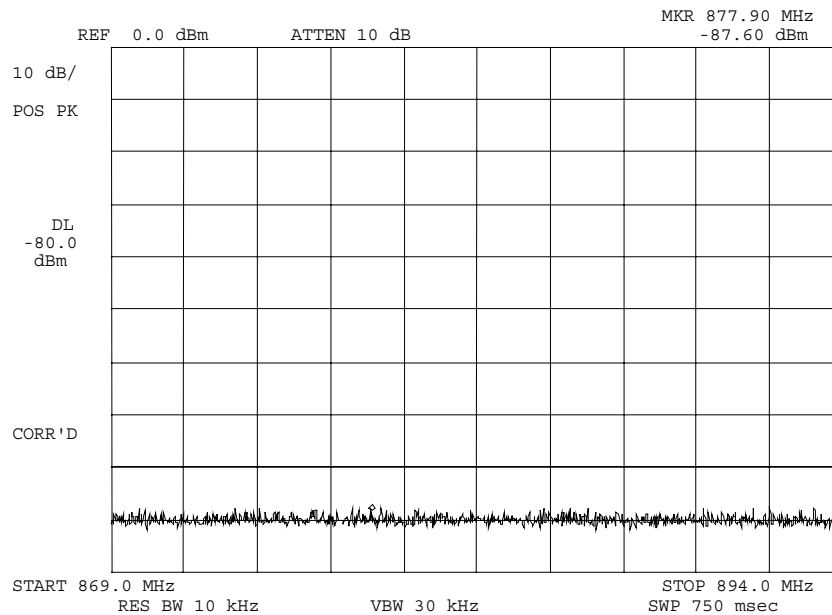
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0030109: 2000-Mar-10 Fri 12:59:00
 STATE: 1:Low Power



POWER:

LOW

MODULATION:

ANY

TX SPURS IN RX CRITICAL
 BAND

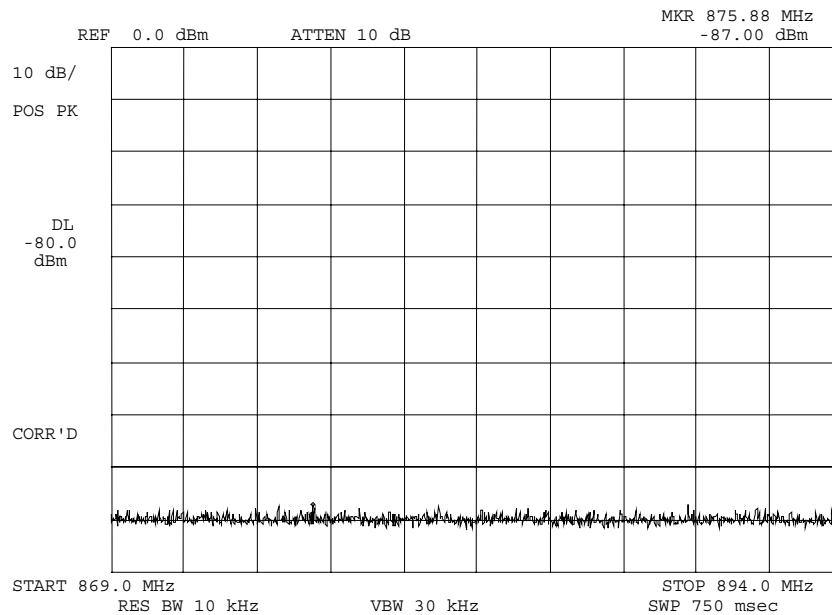
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 of Engineering

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
g0030110: 2000-Mar-10 Fri 13:00:00
STATE: 2:High Power



POWER:

HIGH

MODULATION:

ANY

TX SPURS IN RX CRITICAL
BAND

SUPERVISED BY:

William H. Graff, Director
of Engineering

PAGE NO. 60 of 72.

NAME OF TEST: Spurious Emissions at Antenna Terminals

SPECIFICATION: 47 CFR 2.1051, 22.917

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a Spectrum Analyzer.
2. A notch filter was introduced to reduce or eliminate spurious emission which could be generated internally in the spectrum analyzer.
3. Measurements were made over the range from 45 kHz to 10 GHz for the worst case modulation so both the highest and lowest R.F. power settings.
4. All other emissions were 20 dB or more below the limit.
5. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
6. MEASUREMENT RESULTS: ATTACHED

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0030117: 2000-Mar-10 Fri 13:48:00
 STATE: 2:High Power AMPS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1648.096700	-41.3	-63.4	-28.3
836.400000	1672.813900	-28.7	-50.8	-15.7
848.970000	1697.921500	-44.2	-66.3	-31.2
824.040000	2472.124600	-43	-65.1	-30
836.400000	2509.177500	-43.9	-66	-30.9
848.970000	2546.894100	-50.4	-72.5	-37.4
824.040000	3296.147900	-54.7	-76.8	-41.7
836.400000	3345.613300	-55.7	-77.8	-42.7
848.970000	3395.918100	-54.8	-76.9	-41.8
824.040000	4120.198500	-54.7	-76.8	-41.7
836.400000	4182.045800	-54.8	-76.9	-41.8
848.970000	4244.861400	-54.1	-76.2	-41.1
824.040000	4944.255300	-55.1	-77.2	-42.1
836.400000	5018.405700	-53.7	-75.8	-40.7
848.970000	5093.771600	-55	-77.1	-42
824.040000	5768.247400	-55.4	-77.5	-42.4
836.400000	5854.811700	-48.9	-71	-35.9
848.970000	5942.777800	-48.5	-70.6	-35.5
824.040000	6592.325700	-49.4	-71.5	-36.4
836.400000	6691.200800	-49.1	-71.2	-36.1
848.970000	6791.806700	-48.4	-70.5	-35.4
824.040000	7416.347200	-48.8	-70.9	-35.8
836.400000	7527.576400	-49.2	-71.3	-36.2
848.970000	7640.745500	-49.7	-71.8	-36.7
824.040000	8240.368000	-49.2	-71.3	-36.2
836.400000	8363.969700	-49.1	-71.2	-36.1
848.970000	8489.685800	-48.4	-70.5	-35.4
824.040000	9064.441200	-50.2	-72.3	-37.2
836.400000	9200.382300	-50.2	-72.3	-37.2
848.970000	9338.695800	-49.7	-71.8	-36.7
824.040000	9888.446800	-49.4	-71.5	-36.4
836.400000	10036.823600	-48.1	-70.2	-35.1
848.970000	10187.625800	-48.9	-71	-35.9
824.040000	10712.506100	-48.9	-71	-35.9
836.400000	10873.162200	-49.1	-71.2	-36.1
848.970000	11036.578300	-48.3	-70.4	-35.3
824.040000	11536.546000	-48.5	-70.6	-35.5
836.400000	11709.579500	-49.3	-71.4	-36.3
848.970000	11885.568000	-49.2	-71.3	-36.2
824.040000	12360.557700	-49.1	-71.2	-36.1
836.400000	12545.959100	-44.5	-66.6	-31.5
848.970000	12734.537800	-44.5	-66.6	-31.5

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0030127: 2000-Mar-13 Mon 08:17:00
 STATE: 1:High Power TDMA-AMPS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
824.040000	1648.101100	-33.4	-41.4	-20.4
836.400000	1672.811100	-31.5	-39.5	-18.5
848.970000	1697.927600	-37.2	-45.2	-24.2
824.040000	2472.111300	-39.7	-47.7	-26.7
836.400000	2509.188000	-44.6	-52.6	-31.6
848.970000	2546.935800	-44.7	-52.7	-31.7
824.040000	3296.174600	-70.9	-78.9	-57.9
836.400000	3345.573100	-75.5	-83.5	-62.5
848.970000	3395.910200	-74.1	-82.1	-61.1
824.040000	4120.170000	-75.8	-83.8	-62.8
836.400000	4182.003300	-76.1	-84.1	-63.1
848.970000	4244.871800	-75.4	-83.4	-62.4
824.040000	4944.221400	-75.9	-83.9	-62.9
836.400000	5018.423800	-75.7	-83.7	-62.7
848.970000	5093.868900	-67.6	-75.6	-54.6
824.040000	5768.282400	-75.7	-83.7	-62.7
836.400000	5854.790700	-69.8	-77.8	-56.8
848.970000	5942.781100	-70.8	-78.8	-57.8
824.040000	6592.315000	-70	-78	-57
836.400000	6691.174600	-70.7	-78.7	-57.7
848.970000	6791.722000	-70.2	-78.2	-57.2
824.040000	7416.327600	-69.6	-77.6	-56.6
836.400000	7527.647500	-70.8	-78.8	-57.8
848.970000	7640.682600	-69.1	-77.1	-56.1
824.040000	8240.359700	-69.6	-77.6	-56.6
836.400000	8363.992400	-70.1	-78.1	-57.1
848.970000	8489.718600	-70.8	-78.8	-57.8
824.040000	9064.463200	-69.9	-77.9	-56.9
836.400000	9200.438600	-69.9	-77.9	-56.9
848.970000	9338.685800	-70.3	-78.3	-57.3
824.040000	9888.440500	-70.7	-78.7	-57.7
836.400000	10036.750900	-70.9	-78.9	-57.9
848.970000	10187.619500	-69.8	-77.8	-56.8
824.040000	10712.477600	-70.3	-78.3	-57.3
836.400000	10873.218700	-70.2	-78.2	-57.2
848.970000	11036.614700	-70.5	-78.5	-57.5
824.040000	11536.511400	-69.5	-77.5	-56.5
836.400000	11709.626800	-69.4	-77.4	-56.4
848.970000	11885.566700	-69.6	-77.6	-56.6
824.040000	12360.617200	-70	-78	-57
836.400000	12546.003300	-65.9	-73.9	-52.9
848.970000	12734.521200	-65.9	-73.9	-52.9

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0030129: 2000-Mar-13 Mon 08:49:00
 STATE: 1:High Power TDMA-PCS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
1850.040000	3700.120300	-60.7	-68.7	-47.7
1879.980000	3759.979600	-71.3	-79.3	-58.3
1909.920000	3819.860600	-60.6	-68.6	-47.6
1850.040000	5550.162300	-68.2	-76.2	-55.2
1879.980000	5639.984900	-64.6	-72.6	-51.6
1909.920000	5729.798300	-47	-55	-34
1850.040000	7400.111000	-70.3	-78.3	-57.3
1879.980000	7519.924000	-70.5	-78.5	-57.5
1909.920000	7639.724400	-65.3	-73.3	-52.3
1850.040000	9250.154400	-71.3	-79.3	-58.3
1879.980000	9399.874200	-70.6	-78.6	-57.6
1909.920000	9549.624400	-69.1	-77.1	-56.1
1850.040000	11100.230500	-69.6	-77.6	-56.6
1879.980000	11279.854700	-70.1	-78.1	-57.1
1909.920000	11459.564000	-71	-79	-58
1850.040000	12950.319200	-66.2	-74.2	-53.2
1879.980000	13159.901500	-65.5	-73.5	-52.5
1909.920000	13369.436400	-66.2	-74.2	-53.2
1850.040000	14800.315100	-65.7	-73.7	-52.7
1879.980000	15039.844900	-64	-72	-51
1909.920000	15279.360500	-64.2	-72.2	-51.2
1850.040000	16650.320300	-64.3	-72.3	-51.3
1879.980000	16919.856200	-63.4	-71.4	-50.4
1909.920000	17189.269300	-64.4	-72.4	-51.4
1850.040000	18500.373600	-63.7	-71.7	-50.7
1879.980000	18799.790700	-58.7	-66.7	-45.7
1909.920000	19099.211900	-57.6	-65.6	-44.6
1850.040000	20350.480600	-57.3	-65.3	-44.3
1879.980000	20679.781600	-57	-65	-44
1909.920000	21009.096800	-57	-65	-44

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NAME OF TEST: Field Strength of Spurious Radiation

SPECIFICATION: 47 CFR 2.1053(a)

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. A description of the measurement facilities was filed with the FCC and was found to be in compliance with the requirements of Section 15.38, by letter from the FCC dated March 3, 1997, FILE 31040/SIT. All pertinent changes will be reported to the Commission by up-date prior to March 2000.
2. At first, in order to locate all spurious frequencies and approximate amplitudes, and to determine proper equipment functioning, the test sample was set up at a distance of three meters from the test instrument. Valid spurious signals were determined by switching the power on and off.
3. In the field, the test sample was placed on a wooden turntable above ground at three (or thirty) meters away from the search antenna. Excess power leads were coiled near the power supply.

The cables were oriented in order to obtain the maximum response. At each emission frequency, the turntable was rotated and the search antennas were raised and lowered vertically.
4. The emission was observed with both a vertically polarized and a horizontally polarized search antenna and the worst case was used.
6. The field strength of each emission within 20 dB of the limit was recorded and corrected with the appropriate cable and transducer factors.
7. The worst case for all channels is shown.
8. Measurement results: ATTACHED FOR WORST CASE

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MEASUREMENT RESULTS: FIELD STRENGTH OF SPURIOUS RADIATION

Measurement Distance, m = 3

Spectrum Searched, GHz = 0 to 10

AMPS-FM

TUNED, MHz	CHANNEL NUMBER	EMISSION MHz/HARM.	LEVEL, dBc Hi
824.040	991	2 nd - 10 th	<50
836.400	380	2 nd - 10 th	<50
848.970	799	2 nd - 10 th	<50

AMPS-TDMA

TUNED, MHz	CHANNEL NUMBER	EMISSION MHz/HARM.	LEVEL, dBc Hi
824.040	991	2 nd - 10 th	<55
836.400	380	2 nd - 10 th	<55
848.970	799	2 nd - 10 th	<55

PCS-TDMA

TUNED, MHz	CHANNEL NUMBER	EMISSION MHz/HARM.	LEVEL, dBc Hi
1851.25	2	2 nd - 10 th	<50
1880.00	600	2 nd - 10 th	<50
1908.75	1175	2 nd - 10 th	<50

NOTE:

For channels 380, 799 and 991, the field strength of spurious radiation over the above noted range measured 20 dB or more below the limit.

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William H. Graff, Director
of Engineering

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NAME OF TEST: Field Strength of Spurious Radiation

g0030082: 2000-Mar-01 Wed 14:01:00

STATE: 2:High Power Amps

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	ERP, dBm	MARGIN, dB
836.400000	1672.798000	27.35	31.86	-38.2	-25.2
836.400000	2509.199750	20.92	36.46	-40	-27
836.400000	3345.600550	1.07	38.55	-57.8	-44.8
836.400000	4182.000550	2.49	40.66	-54.2	-41.3
836.400000	5018.400700	4.46	42.95	-50	-37
836.400000	5854.801933	27.33	15.07	-55	-42
836.400000	6691.201867	25.67	18.23	-53.5	-40.5
836.400000	7527.601767	20.33	19.6	-57.4	-44.5
836.400000	8364.002034	16.5	20.04	-60.8	-47.9

NAME OF TEST: Field Strength of Spurious Radiation

g0030083: 2000-Mar-02 Thu 08:37:00

STATE: 2:High Power Amps-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	ERP, dBm	MARGIN, dB
836.400000	1672.798000	17.95	31.86	-47.6	-34.6
836.400000	2509.198000	24.81	36.46	-36.1	-23.1
836.400000	3345.598000	17.75	38.55	-41.1	-28.1
836.400000	4181.998000	11.27	40.66	-45.4	-32.5
836.400000	5018.430000	11.92	42.95	-42.5	-29.5
836.400000	5854.800000	31.83	15.07	-50.5	-37.5
836.400000	6691.200000	33.5	18.23	-45.6	-32.7
836.400000	7527.600000	31.67	19.6	-46.1	-33.1
836.400000	8364.000000	32.17	20.04	-45.2	-32.2

NAME OF TEST: Field Strength of Spurious Radiation

g0030084: 2000-Mar-02 Thu 09:00:00

STATE: 2:High Power PCS-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	EIRP, dBm	MARGIN, dB
1879.980000	3759.998333	47.5	9.56	-38.2	-25.1
1879.980000	5639.967500	45.17	14.55	-35.5	-22.5
1879.980000	7520.005833	32	19.59	-43.6	-30.6
1879.980000	9399.957500	39.67	22.96	-32.6	-19.6
1879.980000	11279.937500	24	23.84	-47.4	-34.4
1879.980000	13159.919166	23.17	26.89	-45.2	-32.1
1879.980000	15039.899166	25.17	23.51	-46.5	-33.5
1879.980000	16919.879166	24.83	30.35	-40	-27

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NAME OF TEST: Frequency Stability (Temperature Variation)

SPECIFICATION: 47 CFR 2.1055(a)(1)

GUIDE: As indicated on page 7

TEST CONDITIONS: As Indicated

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

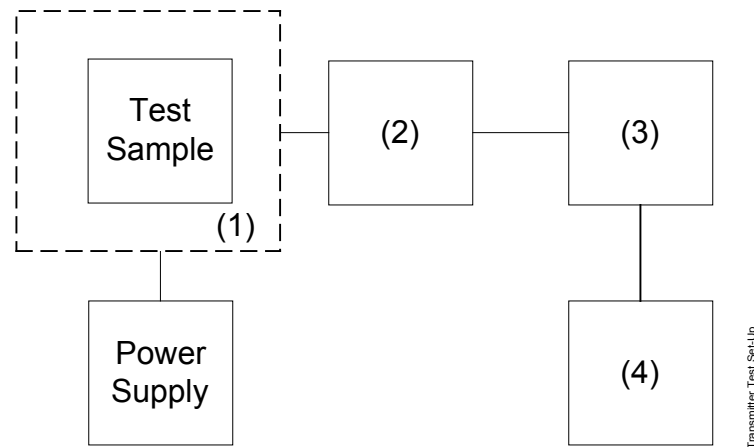
1. The EUT and test equipment were set up as shown on the following page.
2. With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.
4. The temperature tests were performed for the worst case.
5. MEASUREMENT RESULTS: ATTACHED

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TRANSMITTER TEST SET-UP

TEST A. OPERATIONAL STABILITY
 TEST B. CARRIER FREQUENCY STABILITY
 TEST C. OPERATIONAL PERFORMANCE STABILITY
 TEST D. HUMIDITY
 TEST E. VIBRATION
 TEST F. ENVIRONMENTAL TEMPERATURE
 TEST G. FREQUENCY STABILITY: TEMPERATURE VARIATION
 TEST H. FREQUENCY STABILITY: VOLTAGE VARIATION

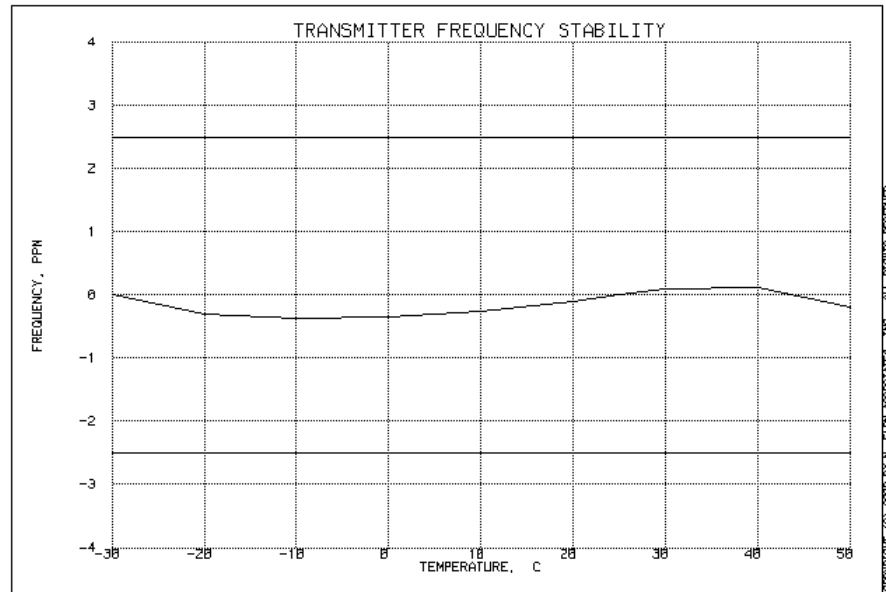


Asset	Description (as applicable)	s/n
(1)	<u>TEMPERATURE, HUMIDITY, VIBRATION</u>	
i00027	Tenny Temp. Chamber	9083-765-234
i00	Weber Humidity Chamber	
i00	L.A.B. RVH 18-100	
(2)	<u>COAXIAL ATTENUATOR</u>	
i00122	NARDA 766-10	7802
i00123	NARDA 766-10	7802A
i00113	SIERRA 661A-3D	1059
i00069	BIRD 8329 (30 dB)	10066
(3)	<u>R.F. POWER</u>	
i00014	HP 435A POWER METER	1733A05839
i00039	HP 436A POWER METER	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(4)	<u>FREQUENCY COUNTER</u>	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A	2105A01087

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NAME OF TEST: Frequency Stability (Temperature Variation)
g0030080: 2000-Mar-13 Mon 09:41:00
STATE: 0:General



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William H. Graff, Director
of Engineering

PAGE NO. 71 of 72.

NAME OF TEST: Frequency Stability (Voltage Variation)

SPECIFICATION: 47 CFR 2.1055 (b) (1)

GUIDE: As indicated on page 7

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at $25 \pm 5^\circ\text{C}$ and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)
g0030094: 2000-Mar-10 Fri 11:53:30
STATE: 0:General

LIMIT, ppm = 2.5
LIMIT, Hz = 2091
BATTERY END POINT (Voltage) = 3.2

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.4	836.399990	-10	-0.01
100	4	836.400000	0	0.00
115	4.6	836.400000	0	0.00
80	3.2	836.399990	-10	-0.01

LIMIT: Must remain within authorized frequency block.

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of Engineering

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NAME OF TEST: Necessary Bandwidth and Emission Bandwidth

SPECIFICATION: 47 CFR 2.202(g)

MODULATION = 40K0F1D

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz	=	10
MAXIMUM DEVIATION (D), kHz	=	10
CONSTANT FACTOR (K)	=	1
NECESSARY BANDWIDTH (B _N), kHz	=	(2xM) + (2xDxK)
	=	40.0

MODULATION = 40K0F8W

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz	=	6
MAXIMUM DEVIATION (D), kHz	=	14
CONSTANT FACTOR (K)	=	1
NECESSARY BANDWIDTH (B _N), kHz	=	(2xM) + (2xDxK)
	=	40.0

MODULATION = 30K0DXW TDMA

NECESSARY BANDWIDTH:

NECESSARY BANDWIDTH (B _N), kHz	=	30.0
(measured at the 99.75% power bandwidth)		

SUPERVISED BY:



William H. Graff, Director
of Engineering

TESTIMONIAL
AND
STATEMENT OF CERTIFICATION

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:



William H. Graff, Director
of Engineering